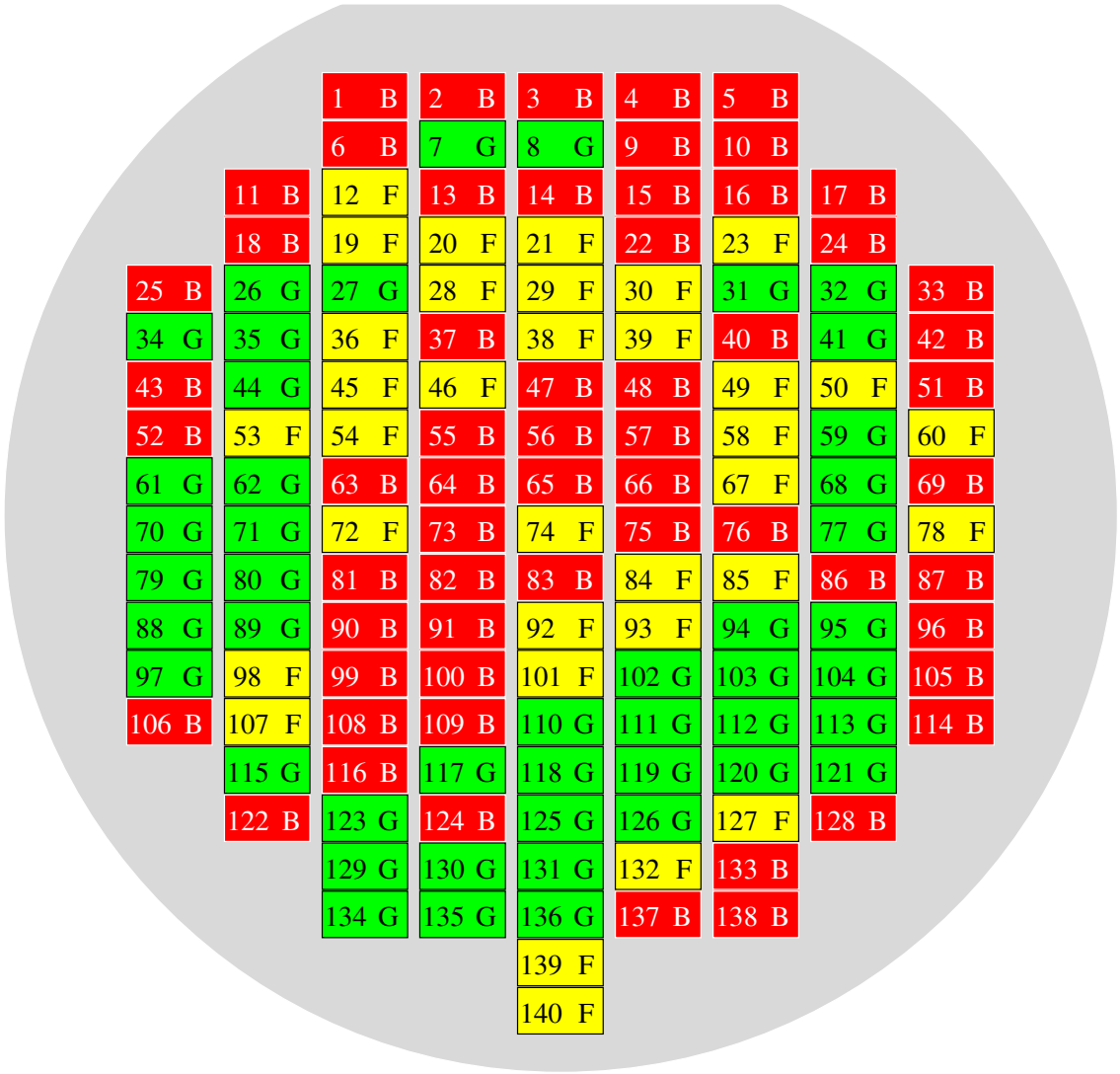
Die quality map for wafer 140 s/n: Y21316-08-17 (not backplated)

Date: 03/23/99



# B	Bad die
# F	Fair die
# G	Good die
# N	No info
# *	Manually tagged